COMPLIANT

FREE Available

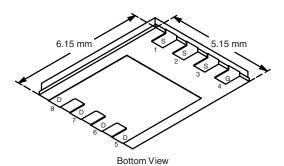




## N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
30	0.0033 at V <sub>GS</sub> = 10 V	40	37 nC		
	$0.0046$ at $V_{GS} = 4.5 \text{ V}$	40	37 110		

### PowerPAK SO-8



Ordering Information: Si7674DP-T1-E3 (Lead (Pb)-free)

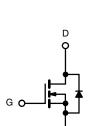
Si7674DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Extremely Low Q<sub>gd</sub> for Switching Losses
- 100 % R<sub>g</sub> Tested
- 100 % Capacitance Tested
- 100 % Avalanche Tested
- Compliant to RoHS Directive 2002/95/EC

### **APPLICATIONS**

Core DC/DC in Notebooks



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		$V_{GS}$	± 20		
	T <sub>C</sub> = 25 °C		40		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	32		
Continuous Brain Carron (1) = 100 C)	T <sub>A</sub> = 25 °C		31 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		25 <sup>b, c</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	70	1	
Continuous Source-Drain Diode Current	$T_C = 25  ^{\circ}C$	I <sub>S</sub>	40		
Continuous Cource Brain Blode Current	T <sub>A</sub> = 25 °C	'5	4.9 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	40	1	
Single Pulse Avalanche Energy		E <sub>AS</sub>	80	mJ	
	$T_C = 25  ^{\circ}C$		83	W	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	53		
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C		5.4 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		3.4 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	18	23	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	1.0	1.5		

### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. See solder profile (<a href="www.vishay.com/ppg?73257">www.vishay.com/ppg?73257</a>). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 65 °C/W.

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SPECIFICATIONS (T <sub>J</sub> = 25 °			N/!	T	Mess	11	
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	V	V -0VI -250 uA	00			\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	00		V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	l <sub>D</sub> = 250 μA		33		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	V V 1 252 4		- 6.3			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1.0		3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1	μΑ	
	500	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	-			μπ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain Source On State Pecietanee	Book	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0027	0.0033	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0038	0.0046		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		87		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			3940	5910	pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		910	1365		
Reverse Transfer Capacitance	C <sub>rss</sub>			305	458		
· ·		V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		60	90	nC	
Total Gate Charge	Qg	B3 + 7 G3 + 7 B +		28	42		
Gate-Source Charge	$Q_{gs}$ $V_{DS} =$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		13.6			
Gate-Drain Charge	Q <sub>gd</sub>	, 50 00		6.8			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		0.95	1.5	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			16	25		
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V, R}_{L} = 1.5 \Omega$		98	150	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		32	50		
Fall Time	t <sub>f</sub>			8	15		
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 15 \text{ V}, R_{I} = 1.5 \Omega$		34	50		
Rise Time	t <sub>r</sub>			210	315		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		26	40		
Fall Time	t <sub>f</sub>	g Salver g		9	15		
Drain-Source Body Diode Characteris	-						
Continuous Source-Drain Diode		T 05 20			40		
Current	l <sub>S</sub>	T <sub>C</sub> = 25 °C			40	Α	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				70		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 5 A		0.75	1.1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			47	70	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1		50	80	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		23		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			24			

### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

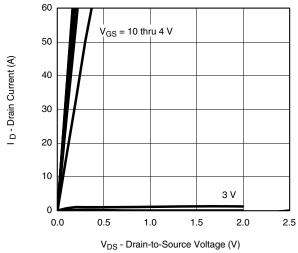
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.



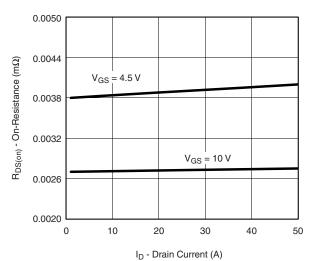


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

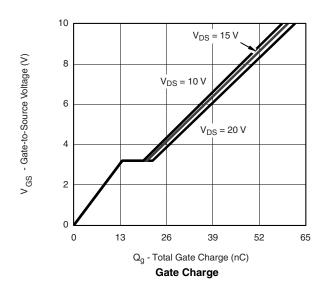


V<sub>DS</sub> - Drain-to-Source Voltage (V)

Output Characteristics



On-Resistance vs. Drain Current and Gate Voltage



2.0

1.6

(Y)

1.2

0.8

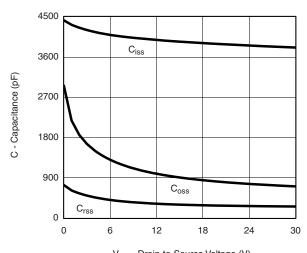
0.4

T<sub>C</sub> = 125 °C

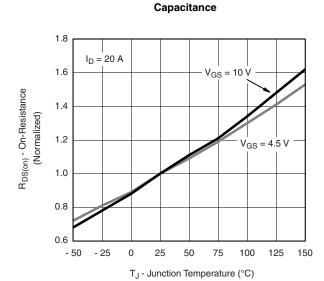
0.0

0 1 2 3 4 5

V<sub>GS</sub> - Gate-to-Source Voltage (V) **Transfer Characteristics** 



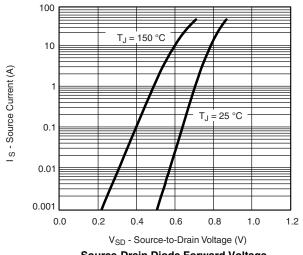
V<sub>DS</sub> - Drain-to-Source Voltage (V)

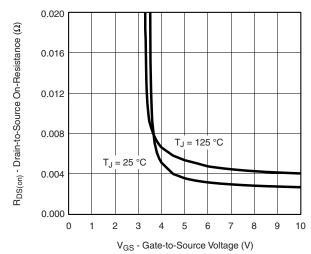


On-Resistance vs. Junction Temperature

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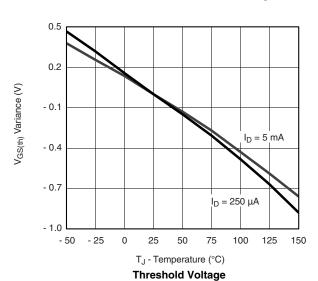
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

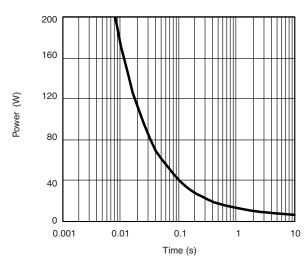




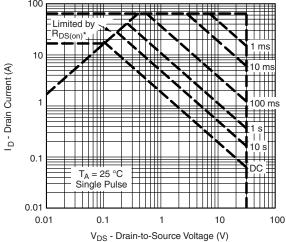
Source-Drain Diode Forward Voltage







Single Pulse Power, Junction-to-Ambient



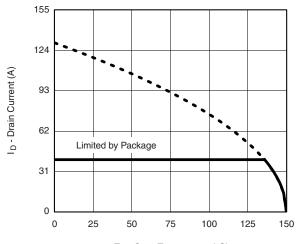
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient



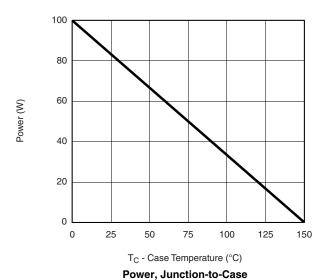


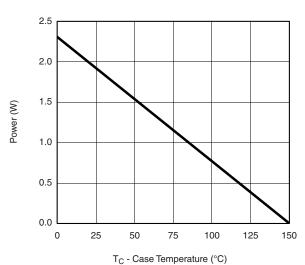
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



 $T_C$  - Case Temperature (°C)

### **Current Derating\***





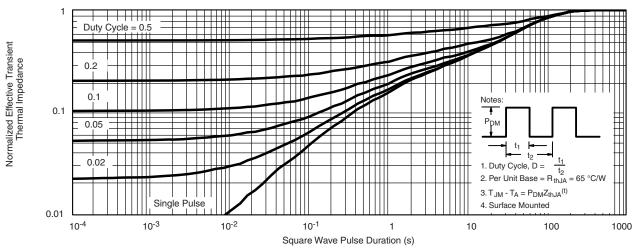
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

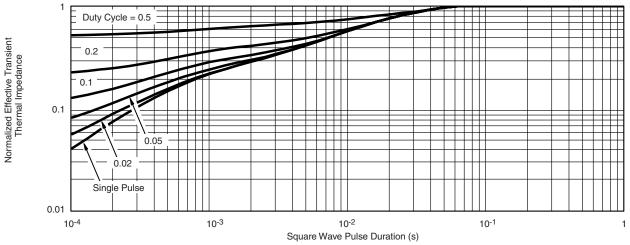
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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